



Docket No.: SON-2780  
(PATENT)

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

In re Patent Application of:

Hiroki Sato et al.

Application No.: 10/603,693

Confirmation No.: 2889

Filed: June 26, 2003

Art Unit: 2622

For: SOLID-STATE IMAGE PICKUP DEVICE  
AND PIXEL DEFECT TESTING METHOD  
THEREOF

Examiner: G. V. Madden

**AMENDMENT AFTER FINAL ACTION UNDER 37 C.F.R. 1.116**

MS AF  
Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Dear Sir:

OK to  
Enter

**INTRODUCTORY COMMENTS**

In full and timely response to the final Office Action dated March 30, 2007, finally rejecting claims 1 to 3 and 5 to 13, please further amend the above-identified U.S. patent application as follows:

*H/M*  
6/21/07

**Amendments to the Claims** are reflected in the listing of claims which begins on page 2 of this paper.

**Remarks/Arguments** begin on page 6 of this paper.